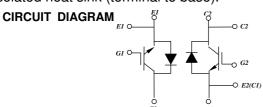
# **MBM400E25E**

Silicon N-channel IGBT

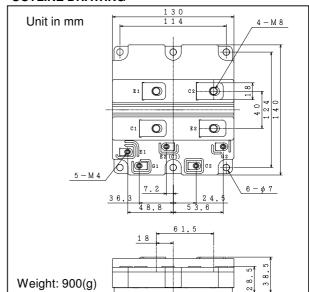
#### **FEATURES**

- \* High speed, low loss IGBT module.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise due to ultra soft fast recovery diode.
- \* High reliability, high durability module.
- \* High thermal fatigue durability. (delta Tc=70K, N>30,000cycles)
- \* Isolated heat sink (terminal to base).



ABSOLUTE MAXIMUM RATINGS (Tc=25°C)

#### **OUTLINE DRAWING**



Item		Symbol	Unit	MBM400E25E	
Collector Emitter Voltage		$V_{CES}$	V	2,500	
Gate Emitter Voltage		$V_{GES}$	V	±20	
Collector Current	DC	Ι <sub>C</sub>	Α	400 (Tc=100 °C)	
Collector Current	1ms	$I_{Cp}$	ζ	800	
Forward Current	DC	I <sub>F</sub>	Α	400	
Torward Gurrent	1ms	$I_{FM}$	ζ	800	
Junction Temperature		Tį	ွင	-40 ~ +150	
Storage Temperature		$T_{stg}$	°C	-40 ~ +125	
Isolation Voltage		$V_{ISO}$	$V_{RMS}$	4,000(AC 1 minute)	
Screw Torque	Terminals (M4/M8)	ı	N∙m	2/15 (1)	
	Mounting (M6)	-	IN III	6 (2)	

Notes: (1) Recommended Value 1.8±0.2/9±1N·m

(2) Recommended Value 5.5±0.5N·m

#### **ELECTRICAL CHARACTERISTICS**

ELECTRICAL CHARACTERISTICS									
Item		Unit	Min.	Тур.	Max.	Test Conditions			
Collector Emitter Cut-Off Current		mA	-	-	4	V <sub>CE</sub> =2,500V, V <sub>GE</sub> =0V, Tj=25°C			
			-	7	20	V <sub>CE</sub> =2,500V, V <sub>GE</sub> =0V, Tj=138°C			
Gate Emitter Leakage Current		nA	-500	-	+500	V <sub>GE</sub> =±20V, V <sub>CE</sub> =0V, Tj=25°C			
Collector Emitter Saturation Voltage		V	1.6	2.3	3.0	I <sub>C</sub> =400A, V <sub>GE</sub> =14.7V, Tj=138°C (chip level)			
Gate Emitter Threshold Voltage		V	4.5	6.0	7.5	V <sub>CE</sub> =15V, I <sub>C</sub> =40mA, Tj=25°C			
Input Capacitance		nF	-	67	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, Tj=25°C			
Internal Gate Resistance		Ω	-	4.8	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, Tj=25°C			
Rise Time	t <sub>r</sub>	μs	0.9	1.5	2.1	V <sub>CC</sub> =1,300V, Ic=150A			
Turn On Time	ton		2.0	2.6	3.2	L=120nH R <sub>G</sub> (ON/OFF)=15/4.7Ω (3) V <sub>GE</sub> = $\pm$ 14.7V, Tj=138°C			
Fall Time	t <sub>f</sub>		0.8	1.4	2.0				
Turn Off Time	t <sub>off</sub>		2.8	3.8	4.8				
Peak Forward Voltage Drop		٧	1.8	2.2	2.8	IF=400A, V <sub>GE</sub> =0V, Tj=138°C (chip level)			
Reverse Recovery Time		μs	0.3	0.6	0.9	Vcc=1,300V, I <sub>F</sub> =150A, L=120nH Tj=138°C			
Turn On Loss		J/P	-	0.25	0.28	V <sub>CC</sub> =1,300V, Ic= I <sub>F</sub> =150A, L=120nH			
Turn Off Loss		J/P	-	0.23	0.30	$R_G(ON/OFF) = 15/4.7\Omega$ (3)			
Reverse Recovery Loss		J/P	-	0.15	0.19	V <sub>GE</sub> =±14.7V, Tj=138°C			
IGBT	Rth(j-c)	K/W	-	-	0.0255	Junction to case (par arm)			
FWD	Rth(j-c)		-	-	0.051				
Contact Thermal Impedance		K/W	-	0.018	-	Case to fin (par arm)			
	Off Current Current Iration Voltage Id Voltage Ince Rise Time Turn On Time Fall Time Turn Off Time E Drop Ince Ince Ince Ince Ince Ince Ince Ince	Symbol   I CES   Current   I GES   I	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			

Notes:(3)  $R_G$  value is the test condition's value for evaluation of the switching times, not recommended value. Please, determine the suitable  $R_G$  value after the measurement of switching waveforms

(overshoot voltage, etc.) with appliance mounted.

- \* Please contact our representatives at order.
- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.



# MBM400E25E

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